



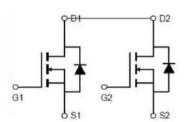
MJ N-Channel Enhancement Mode Power MOSFET

Description

The MJ60ND20AK uses advanced trench technology and design to provide excellent $R_{\text{DS(ON)}}$ with low gate charge. It can be used in a wide variety of applications.

General Features

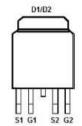
- $ightharpoonup V_{DS} = 60 V, I_D = 20 A$ $m R_{DS(ON)} < 35 m\Omega$ @ VGS=10V $m R_{DS(ON)} < 40 m\Omega$ @ VGS=4.5V
- ♦ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current
- ◆ Good stability and uniformity with high EAS
- ◆ Excellent package for good heat dissipation
- ◆ Special process technology for high ESD capability





Application

- ◆ Power switching application
- ◆ Hard switched and high frequency circuits
- ◆ Uninterruptible power supply



Marking and pin assignment

100% UIS TESTED! 100% ΔVds TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ60ND20AK	MJ60ND20AK	TO-252-4L	4	-	2

Absolute Maximum Ratings (Tc =25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	60	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	ΙD	20	А
Drain Current-Continuous(Tc =100℃)	I D(100℃)	14	Α
Pulsed Drain Current	Ідм	60	Α
Maximum Power Dissipation	PD	45	W
Derating factor		0.3	W/°C
Single pulse avalanche energy (Note 5)	Eas	72	mJ
Operating Junction and Storage Temperature Range	Тл ,Тѕтс	-55 To 175	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	Rejc	3.3	°C/W
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Electrical Characteristics (Tc =25°Cunless otherwise noted)

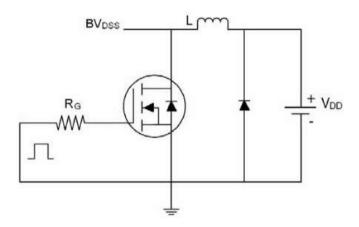
Parameter	Symbol	Condition	Min	Тур	Max	Uni
Off Characteristics						
Drain-Source Breakdown Voltage	BVDSS	V _{GS} =0V I _D =250µA	60	_	-	V
Zero Gate Voltage Drain Current	Ipss	V _{DS} =60V,V _{GS} =0V	_	-	1	μA
Gate-Body Leakage Current	lgss	V _{DS} =±20V,V _{DS} =0V	_	-	±100	nA
On Characteristics (Note 3)	'					
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250μA	1.2	1.6	2.5	V
Davis Course On Otata Basistanas	D	Vgs=10V, Ip=10A	_	24	35	mΩ
Drain-Source On-State Resistance	Rds(on)	V _{GS} =4.5V, I _D =10A	-	30	40	mΩ
Forward Transconductance	grs	V _{DS} =5V,I _D =10A	11	-	-	S
Dynamic Characteristics (Note 4)	'					
Input Capacitance	Clss		-	973	-	PF
Output Capacitance	Coss	V _{DS} =30V,V _{GS} =0V F=1.0MHz	-	61.2	-	PF
Reverse Transfer Capacitance	Crss	-	-	58.8	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	5	-	nS
Turn-on Rise Time	tr	V_{DD} =30V,R _L =6.7Ω V_{GS} =10V,R _G =3Ω $-$ 16.1 $-$ 2.3	-	2.6	-	nS
Turn-Off Delay Time	t _{d(off)}		16.1	-	nS	
Turn-Off Fall Time	tr		-	2.3	-	nS
Total Gate Charge	Qg		_	25	_	nC
Gate-Source Charge	Qgs	V _{DS} =30V,I _D =10A V _{GS} =10V	_	4.5	-	nC
Gate-Drain Charge	Qgd	-	-	6.5	_	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	VsD	V _{GS} =0V,I _S =10A	_	-	1.2	V
Diode Forward Current (Note 2)	Is		_	-	20	А
Reverse Recovery Time	trr	T1=25°C 1=-20^	_	29	-	nS
Reverse Recovery Charge	Qrr	TJ=25°C, IF=20A di/dt=100A/µs (Note 3)	_	49	_	nC
Forward Turn-On Time	ton	Intrinsic turn-on time is n	oglicib!-#	 rn cn != !	omin = t = -! !	\

Notes:

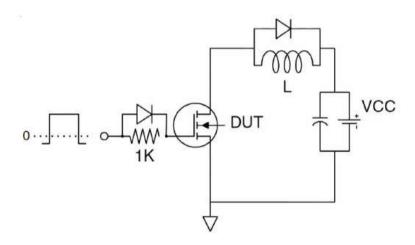
- 1 Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, $t \le 10$ sec.
- ③ Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4 Guaranteed by design, not subject to production
- (§) EAS condition: Tj=25°C,VDD=30V,VG=10V,L=0.5mH,Rg=25 Ω



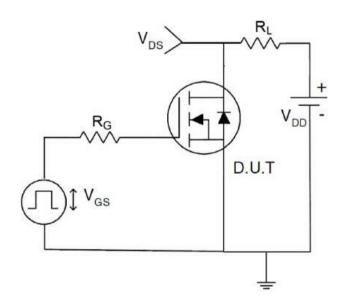
Test circuit



Eas test Circuit



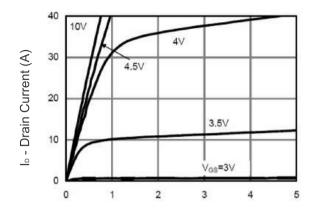
Gate charge test Circuit



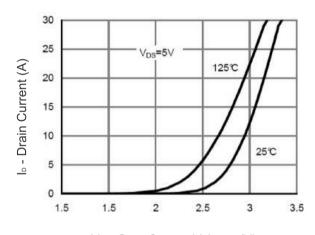
Switch Time Test Circuit



Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V)
Figure 1 Output Characteristics



Vgs Gate-Source Voltage (V)
Figure 2 Transfer Characteristics

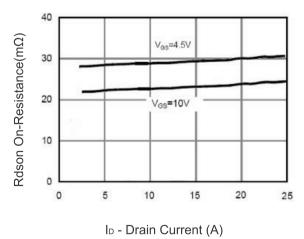
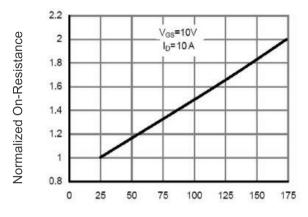
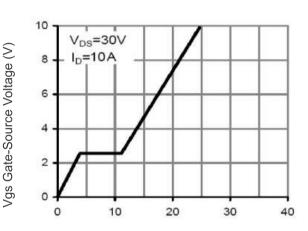


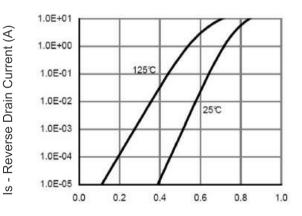
Figure 3 Rdson- Drain Current



T_J -Junction Temperature(°C)
Figure 4 Rdson-Junction Temperature

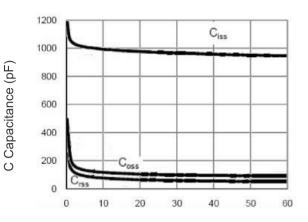


Qg Gate Charge (nC)
Figure 5 Gate Charge

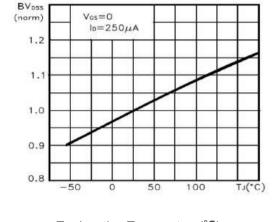


Vsd Source-Drain Voltage (V)
Figure 6 Source- Drain Diode Forward

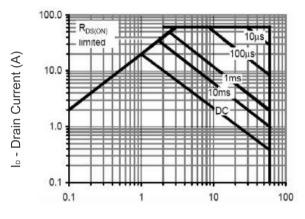




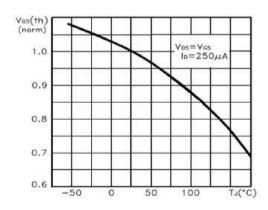
Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds



TJ -Junction Temperature(°C)
Figure 9 BVpss vs Junction Temperature

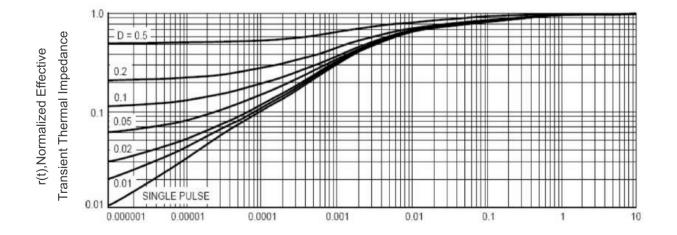


Vds Drain-Source Voltage (V)
Figure 8 Safe Operation Area



T_J -Junction Temperature(°C)

Figure 10 V_{GS(th)} vs Junction Temperature

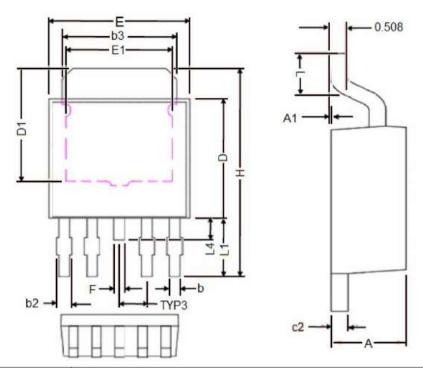


Square Wave Pluse Duration(sec)
Figure 11 Normalized Maximum Transient Thermal Impedance





TO-252-4L Package Information



Symbol		Dimensions In Millimeters	•
Бутьо і	Min.	Nom.	Max.
А	2.20	2.30	2.40
A1	0	0.08	0.15
b	0.45	0.53	0.60
b2	0.50	0.65	0.80
b3	5.20	5.35	5.50
c2	0.45	0.50	0.55
D	5.40	5.60	5.80
D1	4.57	:	4
E	6.40	6.60	6.80
E1	3.81	5	76
е	1.27 REF.		
E1	3.81	i a	70
F	0.40	0.50	0.60
Н	9.40	9.80	10.20
L	1.40	1.59	1.77
L1	2.40	2.70	3.00
L4	0.80	1.00	1.20



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